

**Search Notes**

Application/Control No.

10/694,598

Examiner

Shih-Chao Chen

Applicant(s)/Patent under  
Reexamination

ASAKURA ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	700MS, 702, 846, 895	10/17/2005	CHEN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
343	700MS	10/17/2005	CHEN
343	702	10/17/2005	CHEN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	10/17/2005	CHEN